

MM74C914 Hex Schmitt Trigger with Extended Input Voltage

General Description

The MM74C914 is a monolithic CMOS Hex Schmitt trigger with special input protection scheme. This scheme allows the input voltage levels to exceed V_{CC} or ground by at least 10V ($V_{CC} - 25V$ to $GND + 25V$), and is valuable for applications involving voltage level shifting or mismatched power supplies.

The positive and negative-going threshold voltages, V_{T+} and V_{T-} , show low variation with respect to temperature

(typ 0.0005V/°C at $V_{CC} = 10V$). And the hysteresis, $V_{T+} - V_{T-} \geq 0.2 V_{CC}$ is guaranteed.

Features

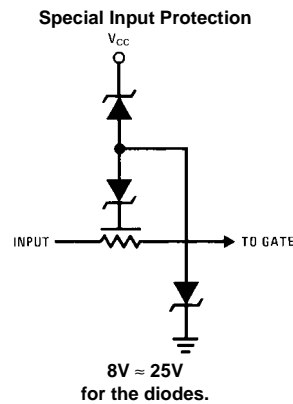
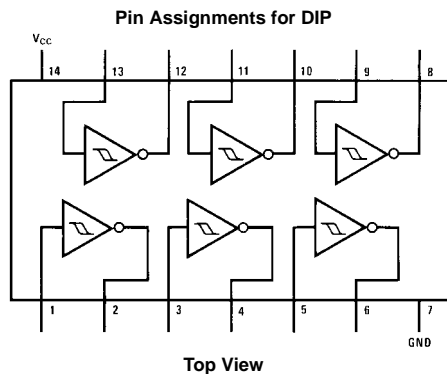
- Hysteresis: 0.45 V_{CC} (typ.) 0.2 V_{CC} guaranteed
- Special input protection: Extended Input Voltage Range
- Wide supply voltage range: 3V to 15V
- High noise immunity: 0.7 V_{CC} (typ.)
- Low power TTL compatibility: Fan out of 2 driving 74L

Ordering Code:

Order Number	Package Number	Package Description
MM74C914M	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150" Narrow
MM74C914N	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code.

Connection Diagrams



Absolute Maximum Ratings (Note 1)		Operating V_{CC} Range	3V to 15V
Voltage at any Input Pin	$V_{CC} - 25V$ to GND + 25V	Absolute Maximum (V_{CC})	18V
Voltage at any other Pin	-0.3V to $V_{CC} + 0.3V$	Lead Temperature (T_L)	300°C
Operating Temperature Range (T_A)	-40°C to +85°C	(Soldering, 10 seconds)	
Storage Temperature Range (T_S)	-65°C to +150°C		
Power Dissipation		Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. Except for "Operating Temperature Range", they are not meant to imply that the devices should be operated at these limits. The Electrical Characteristics tables provide conditions for actual device operation.	
Dual-In-Line	700 mW		
Small Outline	500mW		

DC Electrical Characteristics

Min/Max limits apply across temperature range unless otherwise noted

Symbol	Parameter	Conditions	Min	Typ	Max	Units
CMOS TO CMOS						
V_{T+}	Positive Going Threshold Voltage	$V_{CC} = 5V$	3.0	3.6	4.3	V
		$V_{CC} = 10V$	6.0	6.8	8.6	V
		$V_{CC} = 15V$	9.0	10	12.9	V
V_{T-}	Negative Going Threshold Voltage	$V_{CC} = 5V$	0.7	1.4	2.0	V
		$V_{CC} = 10V$	1.4	3.2	4.0	V
		$V_{CC} = 15V$	2.1	5	6.0	V
$V_{T+} - V_{T-}$	Hysteresis	$V_{CC} = 5V$	1.0	2.2	3.6	V
		$V_{CC} = 10V$	2.0	3.6	7.2	V
		$V_{CC} = 15V$	3.0	5	10.8	V
$V_{OUT(1)}$	Logical "1" Output Voltage	$V_{CC} = 5V, I_O = -10 \mu A$	4.5			V
		$V_{CC} = 10V, I_O = -10 \mu A$	9.0			V
$V_{OUT(0)}$	Logical "0" Output Voltage	$V_{CC} = 5V, I_O = +10 \mu A$			0.5	V
		$V_{CC} = 10V, I_O = +10 \mu A$			1.0	V
$I_{IN(1)}$	Logical "1" Input Current	$V_{CC} = 15V, V_{IN} = 25V$		0.005	5.0	μA
$I_{IN(0)}$	Logical "0" Input Current	$V_{CC} = 15V, V_{IN} = -10V$	-100	-0.005		μA
I_{CC}	Supply Current	$V_{CC} = 15V, V_{IN} = -10V/25V$		0.05	300	μA
		$V_{CC} = 5V, V_{IN} = -2.5V$ (Note 2)		20		μA
		$V_{CC} = 10V, V_{IN} = 5V$ (Note 2)		200		μA
		$V_{CC} = 15V, V_{IN} = 7.5V$ (Note 2)		600		μA
CMOS/LPTTL INTERFACE						
$V_{IN(1)}$	Logical "1" Input Voltage	$V_{CC} = 5V$	4.3			V
$V_{IN(0)}$	Logical "0" Input Voltage	$V_{CC} = 5V$			0.7	V
$V_{OUT(1)}$	Logical "1" Output Voltage	$V_{CC} = 4.75V, I_O = -360 \mu A$	2.4			V
$V_{OUT(0)}$	Logical "0" Output Voltage	$V_{CC} = 4.75V, I_O = 360 \mu A$			0.4	V
OUTPUT DRIVE (See Family Characteristics Data Sheet) (Short Circuit Current)						
I_{SOURCE}	Output Source Current (P-Channel)	$V_{CC} = 5V, V_{OUT} = 0V, T_A = 25^\circ C$	-1.75	-3.3		mA
I_{SOURCE}	Output Source Current (P-Channel)	$V_{CC} = 10V, V_{OUT} = 0V, T_A = 25^\circ C$	-8.0	-15		mA
I_{SINK}	Output Sink Current (N-Channel)	$V_{CC} = 5V, V_{OUT} = V_{CC}, T_A = 25^\circ C$	1.75	3.6		mA
I_{SINK}	Output Sink Current (N-Channel)	$V_{CC} = 10V, V_{OUT} = V_{CC}, T_A = 25^\circ C$	8.0	16		mA

Note 2: Only one input is at $\frac{1}{2} V_{CC}$, the others are either at V_{CC} or GND.

AC Electrical Characteristics (Note 3)

$T_A = 25^\circ\text{C}$, $C_L = 50\text{ pF}$, unless otherwise specified

Symbol	Parameter	Conditions	Min	Typ	Max	Units
t_{PHL}	Propagation Delay from Input to Output	$V_{CC} = 5\text{V}$		220	400	ns
t_{PLH}		$V_{CC} = 10\text{V}$		80	200	ns
C_{IN}	Input Capacitance	Any Input (Note 4)		5		pF
C_{PD}	Power Dissipation Capacitance	Per Gate (Note 5)		20		pF

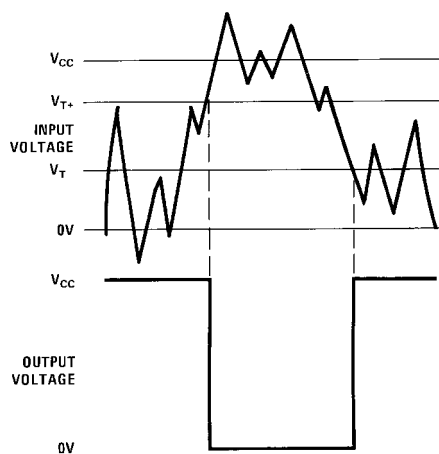
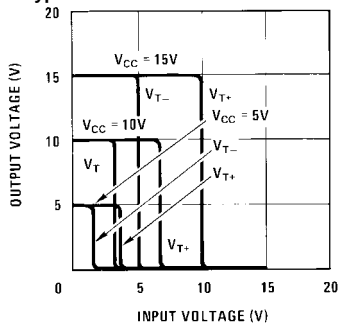
Note 3: AC Parameters are guaranteed by DC correlated testing.

Note 4: Capacitance is guaranteed by periodic testing.

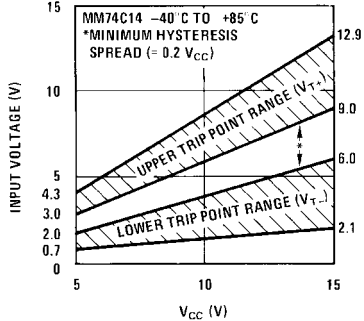
Note 5: C_{PD} determines the no load AC power consumption of any CMOS device. For complete explanation see Family Characteristics Application Note, AN-90.

Typical Performance Characteristics

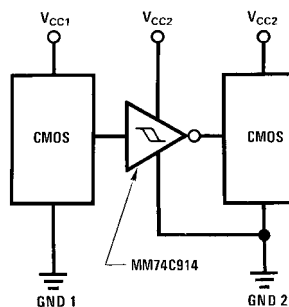
Typical Transfer Characteristics



Guaranteed Trip Point Range



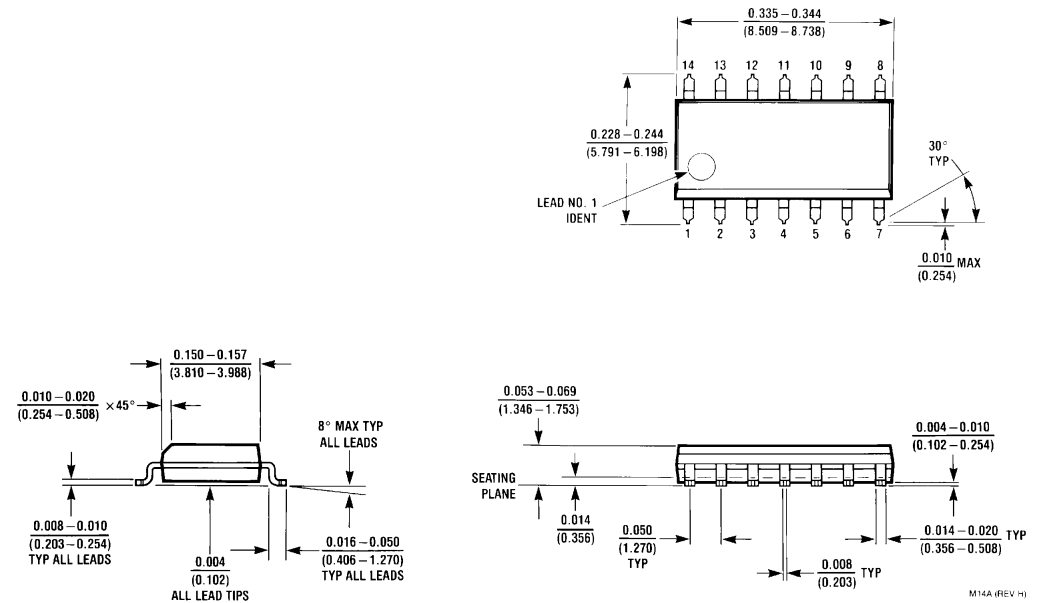
Typical Application



Note: $V_{CC1} = V_{CC2}$
GND1 = GND2

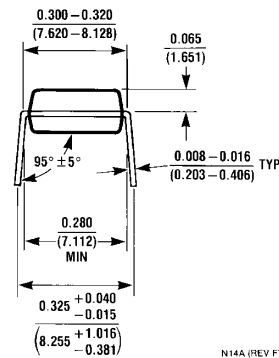
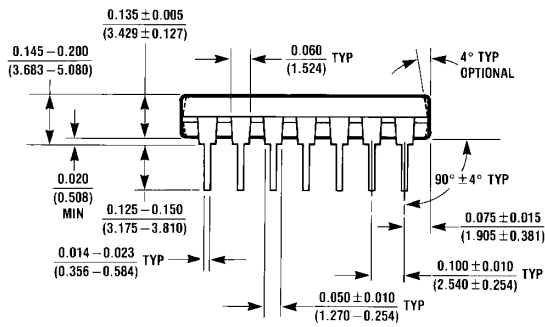
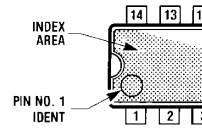
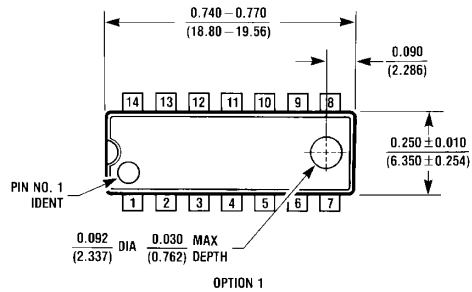
MM74C914

Physical Dimensions inches (millimeters) unless otherwise noted



**14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150" Narrow
Package Number M14A**

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



N14A (REV F)

**14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide
Package Number N14A**

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